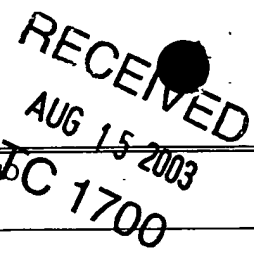

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Form PTO 1 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 210374US0		SERIAL NO. 09/903,785	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Laurence SEBILLOTTE-ARNAUD, et al.			
FILING DATE July 13, 2001				GROUP 1751			
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>W</i>	AA	4,450,090	05/22/84	Kinney, J.			
<i>W</i>	AB	5,824,296	10/20/98	Dubief, et al.			
<i>W</i>	AC	6,277,797	08/21/01	Glenn, Jr., et al.			
<i>W</i>	AD	US 2002/0039976	04/04/02	Sebillotte-Arnaud, et al.			
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
					YES	NO	
<i>W</i>	AO	WO 93/08793	05/13/93	WIPO	X		
<i>W</i>	AP	EP 0 692 248 A1	01/17/96	EPO (English Abstract Provided)		X	
<i>W</i>	AQ	EP 0 514 760 A1	11/25/92	EPO	X		
<i>W</i>	AR	WO 97/49381	12/31/97	WIPO	X		
<i>W</i>	AS	WO 00/38621	07/06/00	WIPO	X		
<i>W</i>	AT	WO 96/28140	09/19/96	WIPO	X		
<i>W</i>	AU	WO 99/38488	08/05/99	WIPO	X		
<i>W</i>	AV	EP 1 172 095	01/16/02	EPO (English Abstract Provided)		X	
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
<i>W</i>	AW	Chemical Abstracts, AN 1987:38232, JP 61 180712, August 13, 1986. XP-002168472					
<i>W</i>	AX	Chemical Abstracts, AN 1992-180847, JP 04 120015, April 21, 1992. XP-002168473					
	AY						
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner <i>W</i>					Date Considered <i>10/30/03</i>		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							